

FORM PTO-1449  
(REV. 7-80)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

212/788

SERIAL NO.

10/550277

LIST OF PRIOR ART CITED BY APPLICANT

(use several sheets if necessary)

APPLICANT

Hartwich et al.

FILING DATE

September 20, 2005

GROUP

Unassigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5,048,623	9/91	Toyada	177	25.8	
	AB	5,885,837	3/99	Winkler et al.	435	91.1	
	AC	2002/0090649	7/02	Chan et al.	435	7.1	
	AD	2002/0095073	7/02	Jacobs et al.	600	300	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	DE 101 039 54 A1		Germany			No
	AM						

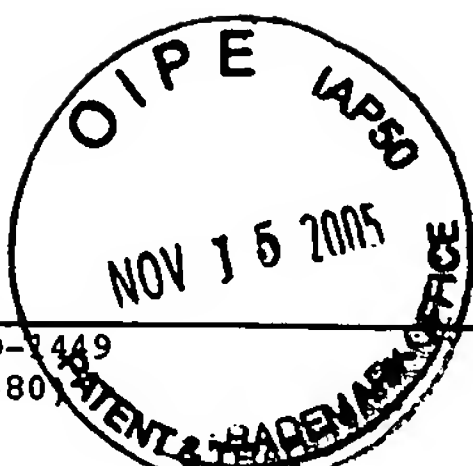
OTHER PRIOR ART (including Author, Title, Date, Pertinent Pages, Etc.)

		Kumar, Patterned Condensation Figures as Optical Diffraction Gratings; G.M. Whitesides, Science, Jan. 7, 1994; pg. 60 - 62

EXAMINER

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Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant



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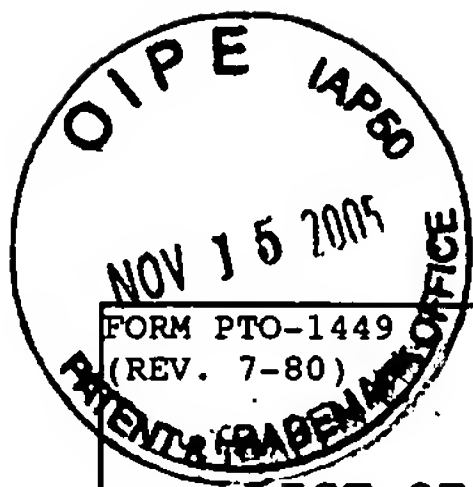
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	WO 02/075775		PCT			No
	AM	EP 0 944 834 B1		Europe			No

OTHER PRIOR ART (including Author, Title, Date, Pertinent Pages, Etc.)


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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	DE 101 56 433 A1		Germany			No
	AM	DE 198 19 537 A1		Germany			No

## OTHER PRIOR ART (including Author, Title, Date, Pertinent Pages, Etc.)


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page 4

FORM PTO-149

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	AL	DE 199 40 750 A1		Germany			No
	AM	WO 02/086162		PCT			No

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